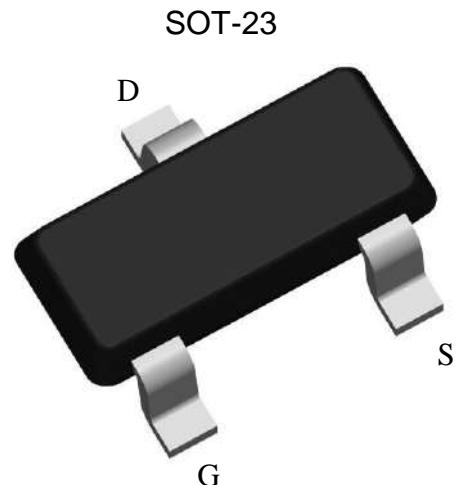


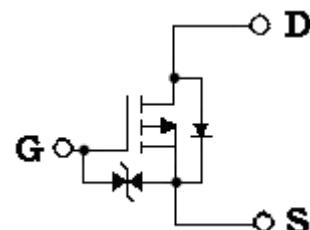
## -100V P-Channel Enhancement Mode MOSFET

### Features:

- Low gate charge
- Compact and low profile SOT-23 package
- Advanced trench process technology
- High density cell design for ultra low on resistance
- ESD protected gate
- Pb-free lead plating package



BVDSS	-100V
ID @ VGS=-10V, TA=25°C	-1.2A
RDSON@VGS=-10V, ID=-1A	440mΩ (typ)
RDSON@VGS=-4.5V, ID=-1A	520mΩ (typ)



G : Gate S : Source D : Drain

### Ordering Information

Device	Package	Shipping
KNB450P10K	SOT-23 (Pb-free lead plating and halogen-free package)	3000 pcs / tape & reel

### Absolute Maximum Ratings ( $T_a=25^\circ C$ )

Parameter	Symbol	Limits	Unit
Drain-Source Voltage	$V_{DS}$	-100	<b>V</b>
Gate-Source Voltage	$V_{GS}$	$\pm 20$	
Continuous Drain Current @ $T_A=25^\circ C$ , $V_{GS}=-10V$ (Note 3)	$I_D$	-1.2	<b>A</b>
Continuous Drain Current @ $T_A=70^\circ C$ , $V_{GS}=-10V$ (Note 3)		-0.96	
Pulsed Drain Current (Notes 1, 2)	$I_{DM}$	-8	
ESD susceptibility (Note 3)	$V_{ESD}$	2500	<b>V</b>
Maximum Power Dissipation (Note 4)	$P_D$	1.38	<b>W</b>
Linear Derating Factor		0.01	<b>W/<math>^\circ C</math></b>
Operating Junction and Storage Temperature Range	$T_j ; T_{stg}$	-55~+150	$^\circ C$

- Note : 1. Pulse width limited by maximum junction temperature.  
 2. Pulse width  $\leq 300\mu s$ , duty cycle  $\leq 2\%$ .  
 3. Human body model,  $1.5k\Omega$  in series with  $100pF$   
 4. Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board;  $270^\circ C/W$  when mounted on minimum copper pad

### Thermal Performance

Parameter	Symbol	Limit	Unit
Thermal Resistance, Junction-to-Ambient(PCB mounted)	$R_{th,ja}$	90	$^\circ C/W$

Note : Surface mounted on 1 in<sup>2</sup> copper pad of FR-4 board;  $270^\circ C/W$  when mounted on minimum copper pad

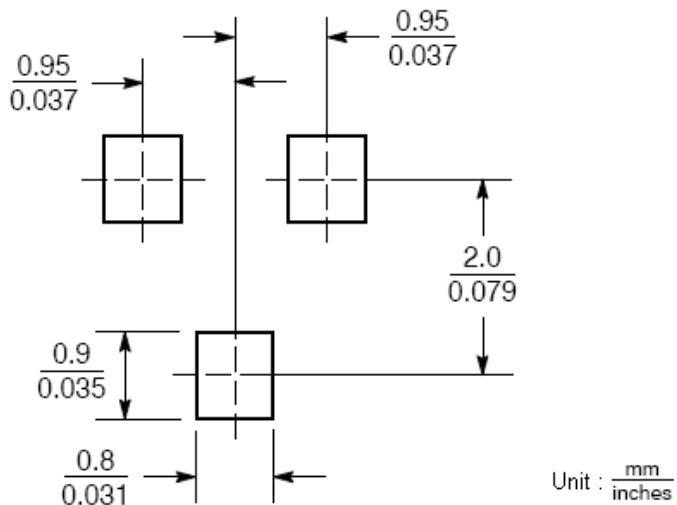
### Electrical Characteristics ( $T_j=25^\circ C$ , unless otherwise noted)

Symbol	Min.	Typ.	Max.	Unit	Test Conditions	
<b>Static</b>						
$BV_{DSS}$	-100	-	-	<b>V</b>	$V_{GS}=0V$ , $I_D=-250\mu A$	
$\Delta BV_{DSS}/\Delta T_j$	-	-0.1	-	$V/^\circ C$	Reference to $25^\circ C$ , $I_D=-250\mu A$	
$V_{GS(th)}$	-1	-	-2.5	<b>V</b>	$V_{DS}=V_{GS}$ , $I_D=-250\mu A$	
$I_{GSS}$	-	-	$\pm 10$	$\mu A$	$V_{GS}=\pm 16V$ , $V_{DS}=0V$	
$ID_{SS}$	-	-	-1		$V_{DS}=-80V$ , $V_{GS}=0V$	
	-	-	-10		$V_{DS}=-80V$ , $V_{GS}=0V$ ( $T_j=70^\circ C$ )	
$*R_{DS(ON)}$	-	440	600	$m\Omega$	$V_{GS}=-10V$ , $I_D=-1A$	
	-	520	725		$V_{GS}=-4.5V$ , $I_D=-1A$	
$*G_{FS}$	-	2.5	-	<b>S</b>	$V_{DS}=-10V$ , $I_D=-1A$	
<b>Dynamic</b>						
$C_{iss}$	-	270	-	$pF$	$V_{DS}=-50V$ , $V_{GS}=0V$ , $f=1MHz$	
$C_{oss}$	-	20	-			
$C_{rss}$	-	21	-			
$t_{d(ON)}$	-	8.2	-	$ns$	$V_{DS}=-50V$ , $I_D=-1A$ , $V_{GS}=-10V$ , $R_G=6\Omega$	
$t_r$	-	1.2	-			
$t_{d(OFF)}$	-	20.8	-			
$t_f$	-	1.8	-			

Qg	-	6.6	-	nC	V <sub>DS</sub> =-50V, I <sub>D</sub> =-1A, V <sub>GS</sub> =-10V
Qgs	-	1	-		
Qgd	-	1.5	-		
R <sub>g</sub>	-	5.4	-	Ω	f=1MHz
<b>Source-Drain Diode</b>					
*V <sub>SD</sub>	-	-0.82	-1.2	V	V <sub>GS</sub> =0V, I <sub>S</sub> =-1A
T <sub>rr</sub>	-	16.9	-	ns	V <sub>GS</sub> =0V, I <sub>F</sub> =-1A, dI <sub>F</sub> /dt=100A/μs
Q <sub>rr</sub>	-	12.3	-	nC	

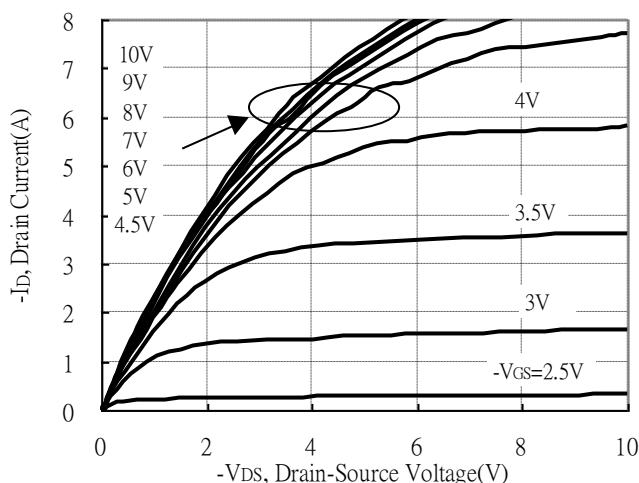
\*Pulse Test : Pulse Width ≤300μs, Duty Cycle≤2%

## Recommended Soldering Footprint

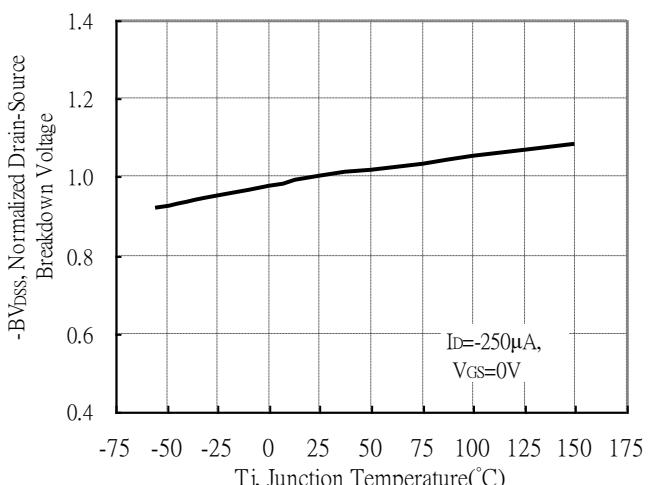


## Typical Characteristics

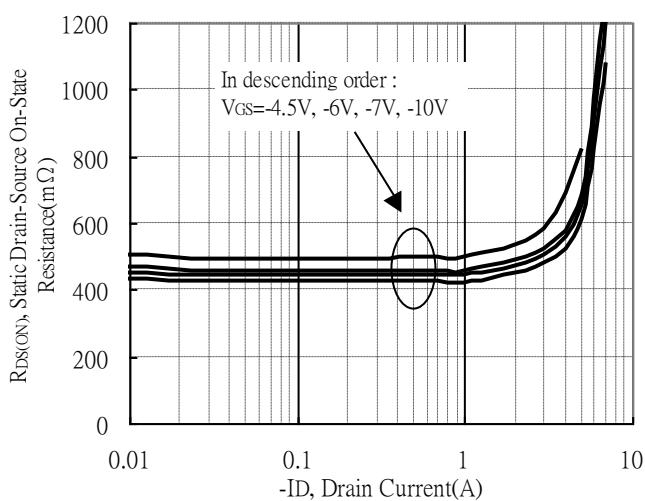
Typical Output Characteristics



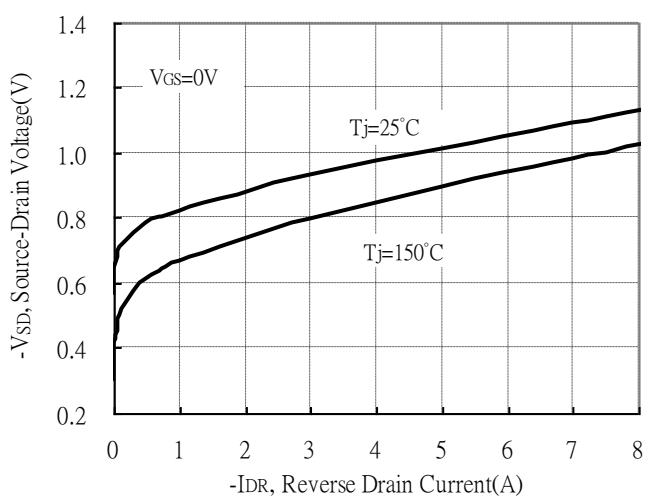
Breakdown Voltage vs Ambient Temperature



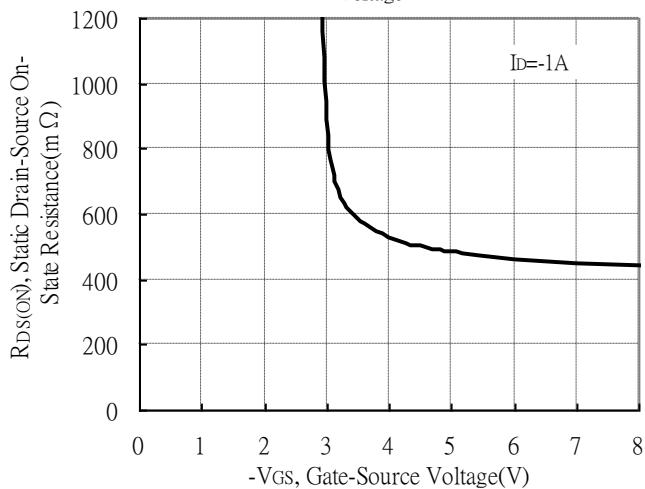
Static Drain-Source On-State resistance vs Drain Current



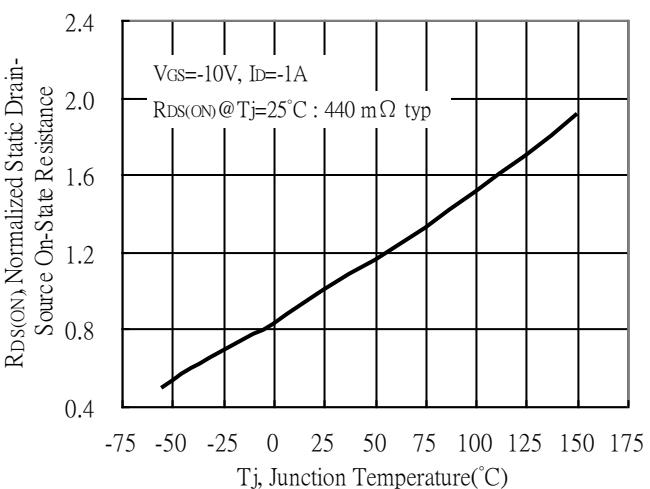
Reverse Drain Current vs Source-Drain Voltage



Static Drain-Source On-State Resistance vs Gate-Source Voltage

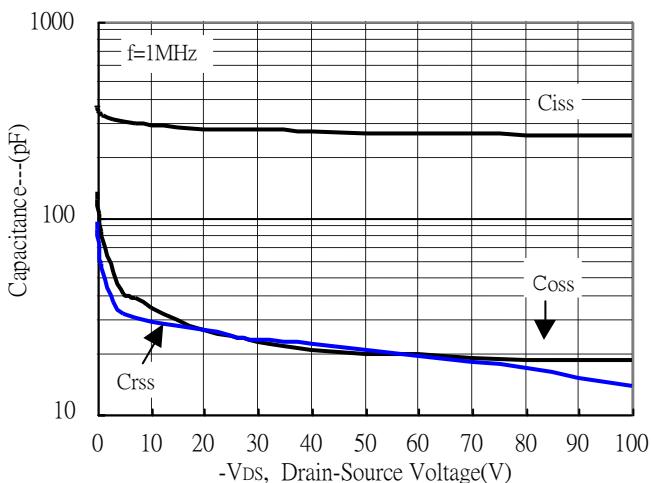


Drain-Source On-State Resistance vs Junction Temperature

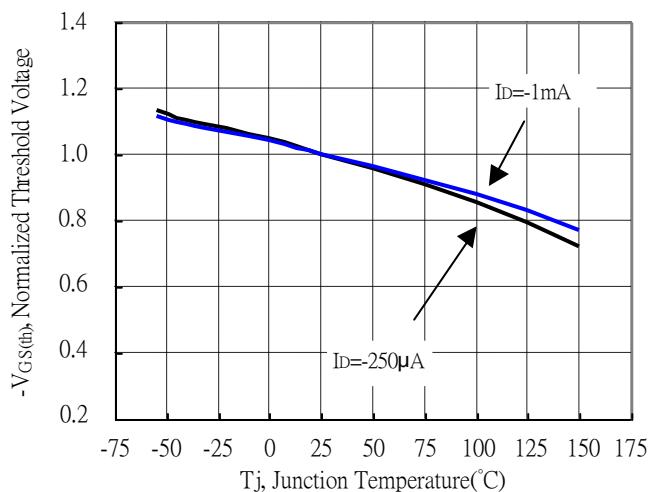


## Typical Characteristics(Cont.)

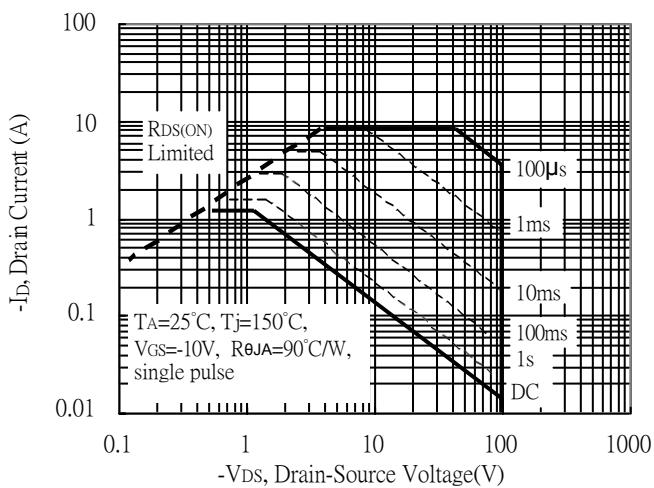
Capacitance vs Drain-to-Source Voltage



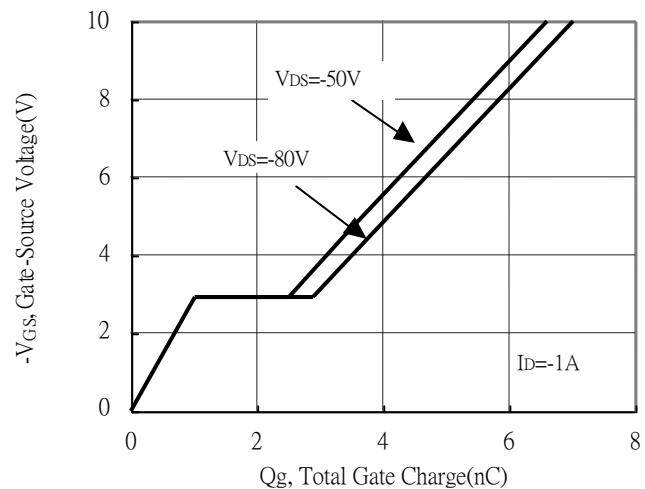
Threshold Voltage vs Junction Temperature



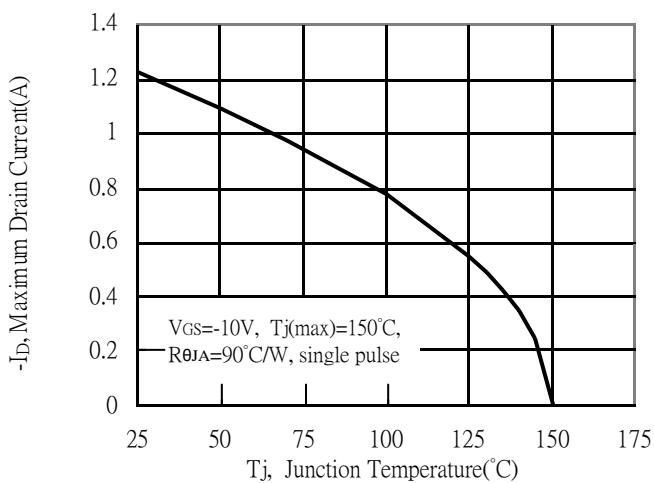
Maximum Safe Operating Area



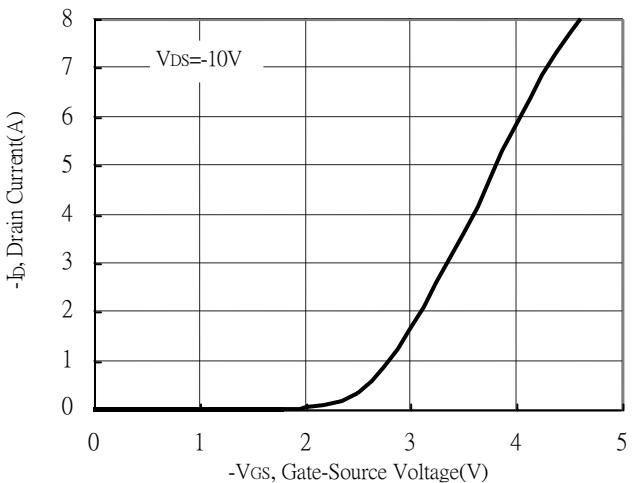
Gate Charge Characteristics



Maximum Drain Current vs Junction Temperature

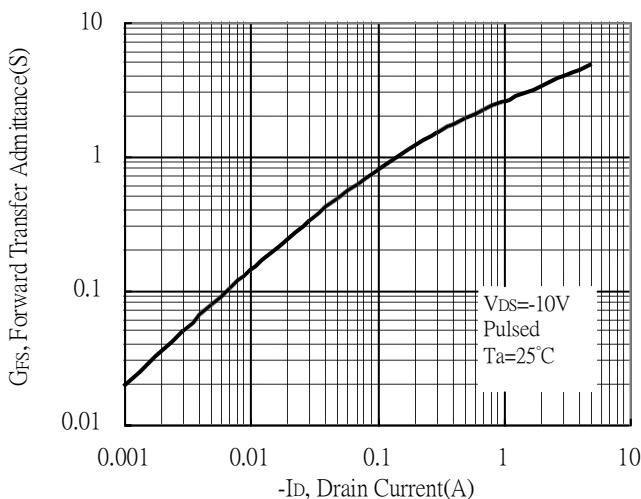


Typical Transfer Characteristics

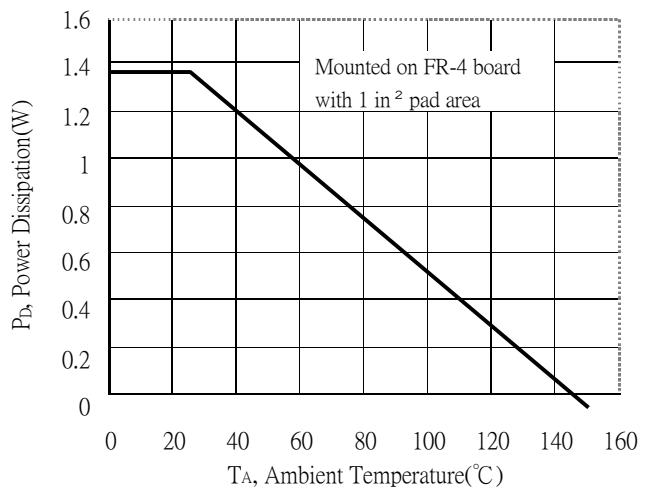


## Typical Characteristics(Cont.)

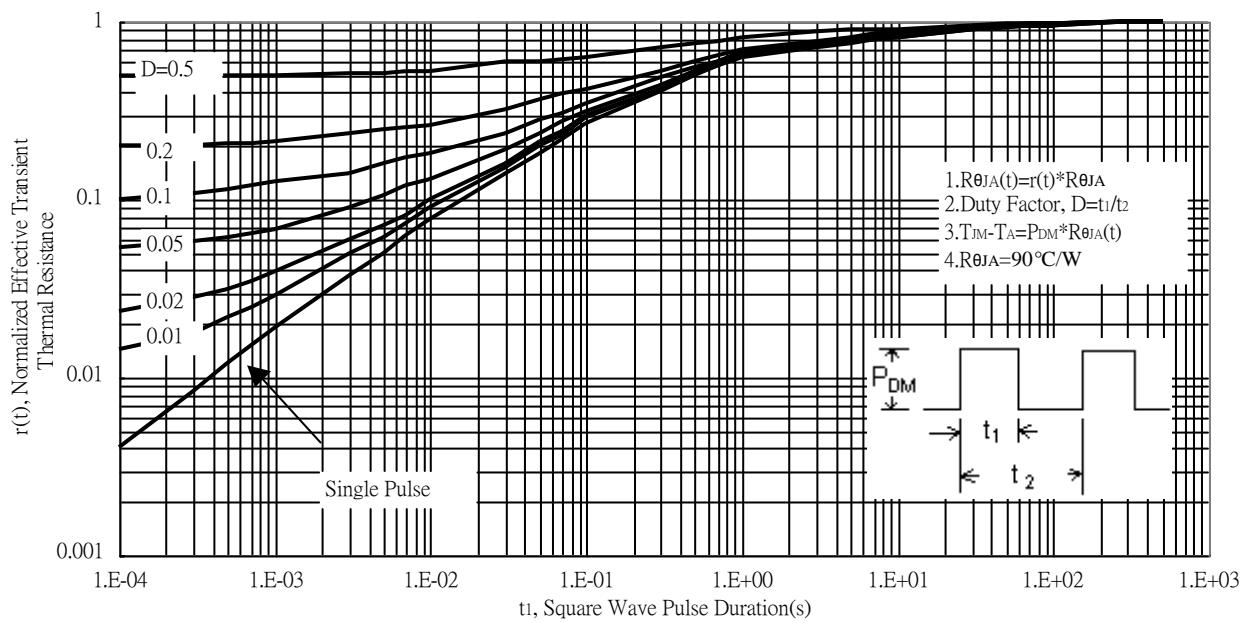
Forward Transfer Admittance vs Drain Current



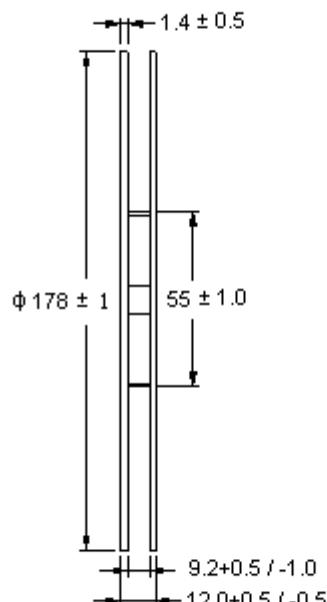
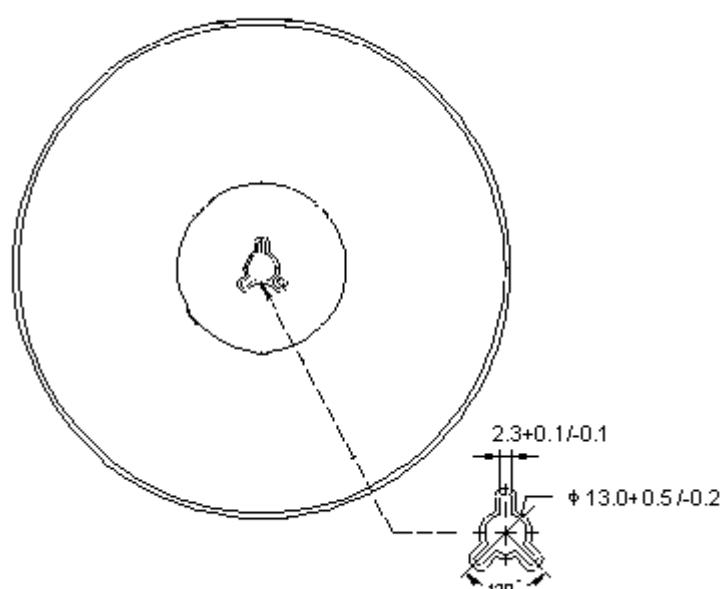
Power Derating Curve



Transient Thermal Response Curves

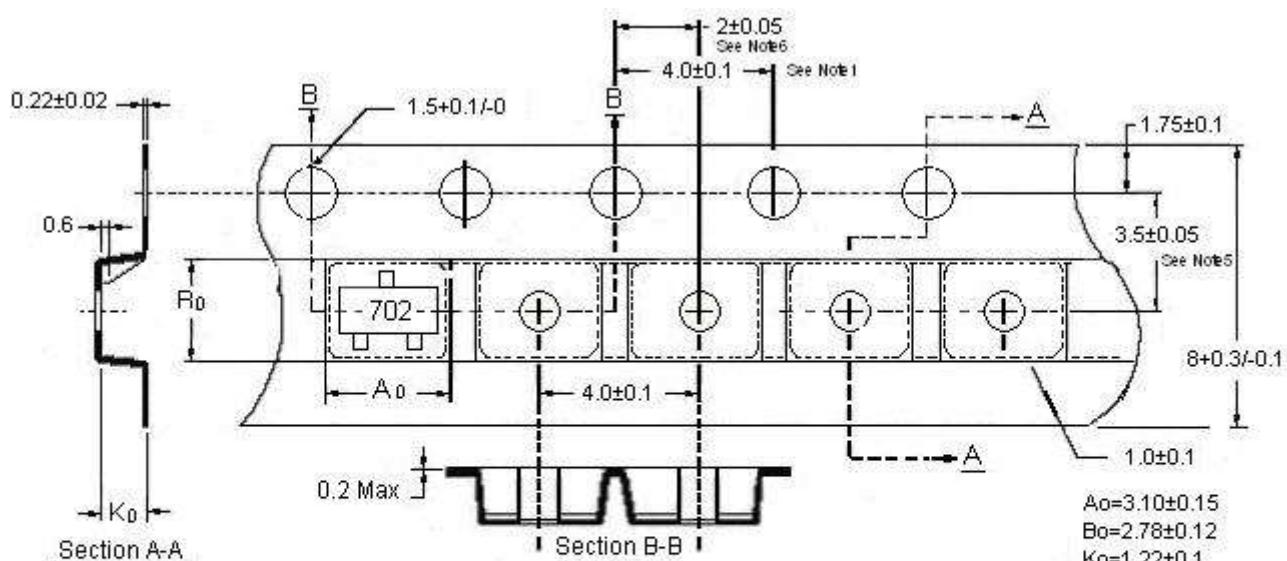


## Reel Dimension



Unit: millimeter

## Carrier Tape Dimension

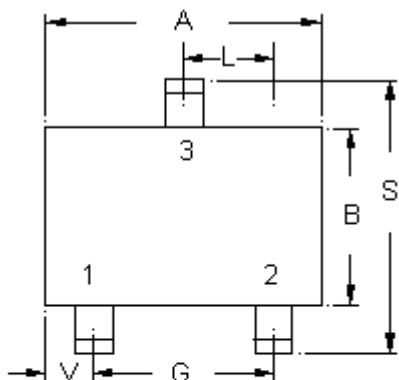


Notes:

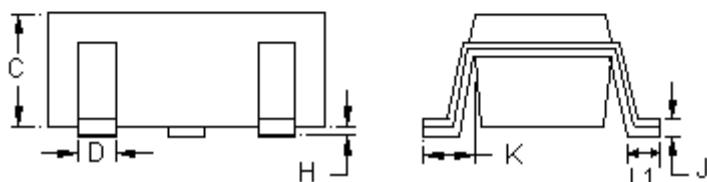
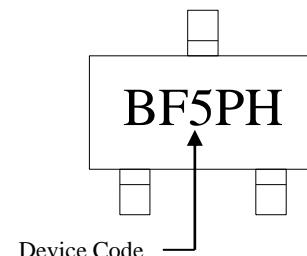
1. 10 sprocket hole pitch cumulative tolerance  $\pm 0.2$ .
2. Camber not to exceed 1mm in 100mm.
3. Material : conductive Black Polystyrene.
4.  $A_0$  &  $B_0$  measured on a plane 0.3mm above the bottom of the pocket.
5.  $K_0$  measured from a plane on the inside bottom of the pocket to the top surface of the carrier.
6. Pocket position relative to sprocket hole measured as true position of pocket, not pocket hole.

Unit : millimeter

## SOT-23 Dimension



Marking:



3-Lead SOT-23 Plastic Surface Mounted Package

Style: Pin 1.Gate 2.Source 3.Drain

\*: Typical

DIM	Inches		Millimeters		DIM	Inches		Millimeters	
	Min.	Max.	Min.	Max.		Min.	Max.	Min.	Max.
A	0.1102	0.1204	2.80	3.04	J	0.0032	0.0079	0.08	0.20
B	0.0472	0.0551	1.20	1.40	K	0.0118	0.0266	0.30	0.67
C	0.0335	0.0512	0.89	1.30	L	0.0335	0.0453	0.85	1.15
D	0.0118	0.0197	0.30	0.50	S	0.0830	0.1004	2.10	2.55
G	0.0669	0.0910	1.70	2.30	V	0.0098	0.0256	0.25	0.65
H	0.0000	0.0040	0.00	0.10	L1	0.0118	0.0197	0.30	0.50